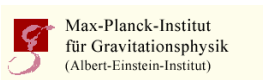


Overview on Low-flux Detectors

J. Eike von Seggern for the ALPS collaboration

DESY Hamburg

9th Patras Workshop, Schloß Waldthausen, Mainz
Wednesday, 26. June 2013



- Very low noise detectors necessary to find/constrain low flux
- $\mathcal{O}(\text{few eV}) \Rightarrow$ optics/ext. background easy
but int. background difficult
- Overlap with QI requirements
- To reduce int. background go to cryogenic temperatures

(Eisamann, et. al: Rev. Sci. Instrum. 82, 071101 (2011))

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\Rightarrow Expect some options

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Outline

- 1 CCD
- 2 Cryogenic detectors
- 3 PMT
- 4 Conclusions

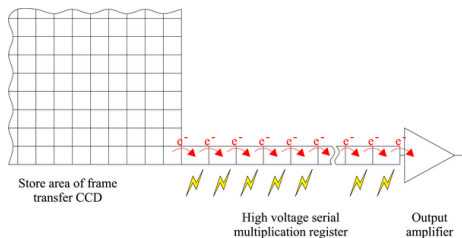
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- Exemplary: PIXIS CCD used in ALPS-I
- Works out of the box
- Cooled to $-70\text{ }^{\circ}\text{C}$
 \Rightarrow dark count rate $R_{\text{DN}} = 7.5 \cdot 10^{-4} \frac{\text{ADU}}{\text{px s}}$
- Slow read-out
 \Rightarrow low RO-noise: $\sigma_{\text{RO}} = 4.2 \text{ ADU}$
- Low gain: $1.02 \frac{e^{-}}{\text{ADU}}$
- Pixel size: $13 \mu\text{m}$
- Sensitivity: $\approx 6 \cdot 10^{-4} \frac{\text{photons}}{\text{s px}}$ (95 % CL)
(with 100 h dark and 20 h bright data, 80 % QE (@532 nm))



Faint Flux EMCCD

- EMCCD: Multiply collected charges before RO-register
- Allows to ignore read-out noise
- Gain of EM $\mathcal{O}(1000)$
- Interpret pixel value as **binary**:
photon detected yes/no?
(problematic for “high” fluxes: coincidences, CIC)
- “Count” photon if output signal $> k\sigma$
- Sensitivity: $\approx 2.8 \cdot 10^{-4} \frac{\text{photons}}{\text{s px}}$ (95 % CL)
(with 20 h bright data, 80 % QE (@532 nm), $R_{\text{DN}} = 7.5 \cdot 10^{-4} \frac{\text{ADU}}{\text{s px}}$)



One cannot beat dark noise!
→ Cryogenic temperatures

(Daigle, et. al.: [0908.0528])

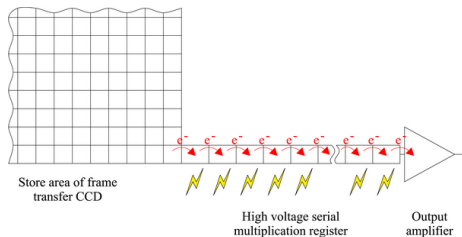
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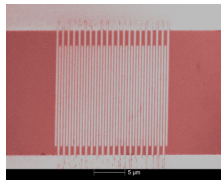
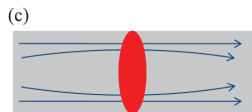
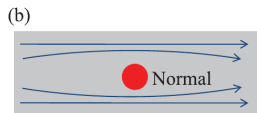
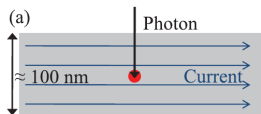


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Superconducting Nanowire single-photon detector (SNSPD)

- SC nano wire with bias current just below j_{crit}
- Absorbed photon creates normal conducting region
- Flux is expelled \Rightarrow flux density $> j_{\text{crit}}$
- Operating temperature $\lesssim 4$ K
- Meandering layout to create sensitive area $\mathcal{O}(10 \times 10 \mu\text{m}^2)$
- Optical cavity to increase absorption efficiency
- Achieved efficiency $\sim 60\%$ @NIR
- But dark count rate $> 0.1 \frac{\text{cnt}}{\text{s}}$ (Shen, Yang, Lou 2010)



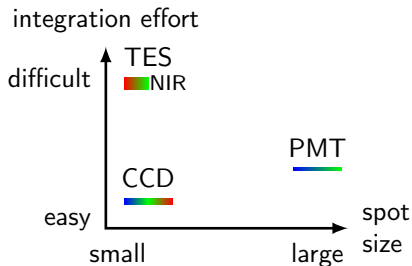
- Bolometric detector:
photon absorption \rightarrow temp. rise \rightarrow signal
- Cryogenic read out: SQUID
- Couple signal into fiber
- High QE (almost 100 %) for target wavelength
- Very low noise $\sim 10^{-3} \frac{\text{cnt}}{\text{s}}$
(hopefully $< \sim 10^{-5} \frac{\text{cnt}}{\text{s}}$)
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For more details cf. talks by G. Cantatore & J. Dreyling-Eschweiler

- Large sensitive area
- Limited spectral range: 300–650 nm
- Limited QE: $\lesssim 30\%$
- Low dark count rate, e.g. $\sim 0.5 \frac{\text{cnt}}{\text{s}}$ for 2.5 cm^2 sens. area
 \Rightarrow very good $R_{\text{DN}}/A_{\text{sens}}$
- Sensitivity: $\approx 1.7 \cdot 10^{-2} \frac{\text{photons}}{\text{s px}}$ (95 % CL)
- Superior to CCDs when signal cannot be focused on a few pixels

Conclusion



- Less options than I expected!
- Many devices still noisy (SNSPD, ...)
- Small spots:
 - CCD: easy but noisy
 - If you have the resources:
Go for a TES!
- Large spots: PMT